

Features

- Uses CRM(CQ) advanced SkyMOS1 technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- Qualified according to JEDEC criteria

Product Summary

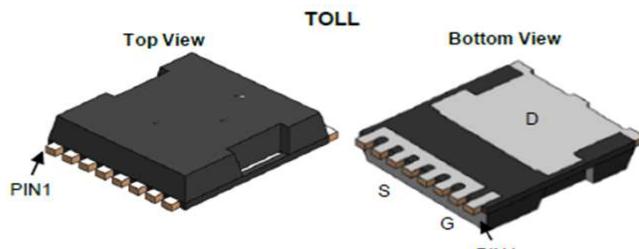
V_{DS}	100V
$R_{DS(on)}$	2mΩ
I_D	240A

Applications

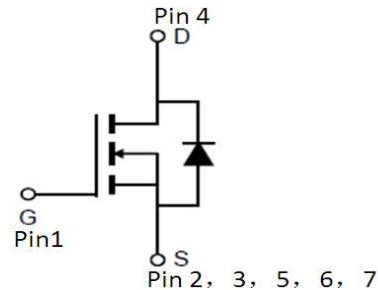
- Motor control and drive
- Battery management
- UPS (Uninterruptible Power Supplies)

100% DVDS Tested

100% Avalanche Tested



CRSZ025N10NZ



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRSZ025N10NZ	CRSZ025N10NZ	TOLL	Tape	N/A	N/A	-

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	100	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 25^\circ\text{C}$ (Package limit) $T_C = 100^\circ\text{C}$ (Silicon limit)	I_D	264 240 155	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax})	$I_{D\text{ pulse}}$	960	A
Avalanche energy, single pulse ($L=0.5\text{mH}$, $R_g=25\Omega$) ^[1]	E_{AS}	529	mJ
Gate-Source voltage	V_{GS}	± 20	V
Power dissipation ($T_C = 25^\circ\text{C}$)	P_{tot}	272	W
Operating junction and storage temperature	T_j , T_{stg}	-55...+150	°C

Notes: 1. EAS was tested at $T_j = 25^\circ\text{C}$, $ID = 46\text{A}$.

Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R _{thJC}	0.46	°C/W
Thermal resistance, junction – ambient(min. footprint)	R _{thJA}	46	

Electrical Characteristic (at T_j = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV _{DSS}	100	-	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	2	3	4	V	V _{DS} =V _{GS} , I _D =250uA
Zero gate voltage drain current	I _{DSS}	-	0.05	1	μA	V _{DS} =100V, V _{GS} =0V T _j =25°C T _j =150°C
Gate-source leakage current	I _{GSS}	-	±10	±100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	2.0	2.5	mΩ	V _{GS} =10V, I _D =100A
Transconductance	g _{fs}	-	197.2	-	S	V _{DS} =5V, I _D =100A

Dynamic Characteristic

Input Capacitance	C _{iss}	7570	11355	17032.5	pF	V _{GS} =0V, V _{DS} =50V, f=1MHz
Output Capacitance	C _{oss}	964	1446	2169		
Reverse Transfer Capacitance	C _{rss}	36	54	81		
Gate Total Charge	Q _G	113	169	254	nC	V _{GS} =10V, V _{DS} =50V, I _D =100A, f=1MHz
Gate-Source charge	Q _{gs}	45	67	101		
Gate-Drain charge	Q _{gd}	20	30	45		
Turn-on delay time	t _{d(on)}	23	35	53	ns	V _{GS} =10V, V _{DD} =50V, R _{G_ext} =3.0Ω
Rise time	t _r	74	111	167		
Turn-off delay time	t _{d(off)}	56	84	126		
Fall time	t _f	75	112	168		
Gate resistance	R _G	1	1.7	3	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz



CRSZ025N10NZ

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SkyMOS1 N-MOSFET 100V, 2mΩ, 240A

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V _{SD}	0.5	0.9	1.4	V	V _{GS} =0V, I _{SD} =100A
Body Diode Reverse Recovery Time	t _{rr}	51	101	202	ns	I _F =100A, dI/dt=100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	169	338	676	nC	

Typical Performance Characteristics

Fig 1: Output Characteristics

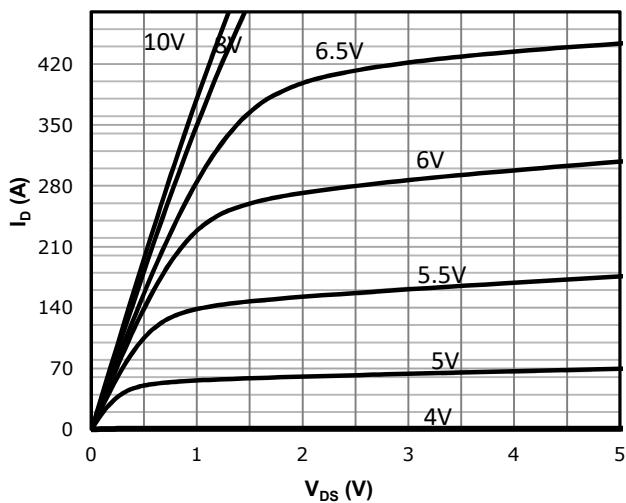


Fig 2: Transfer Characteristics

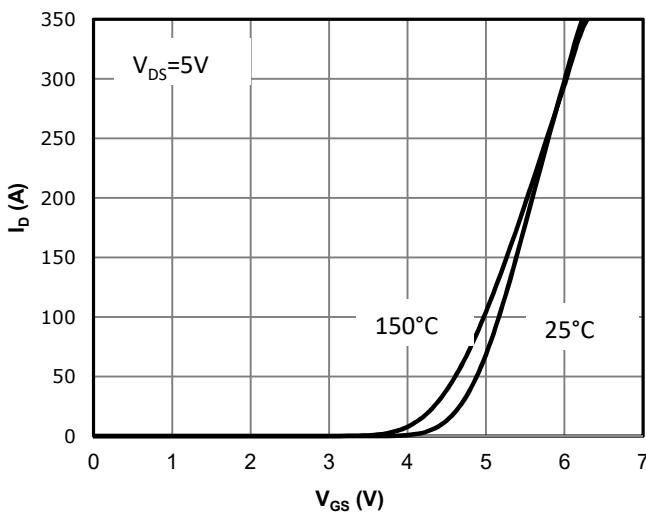
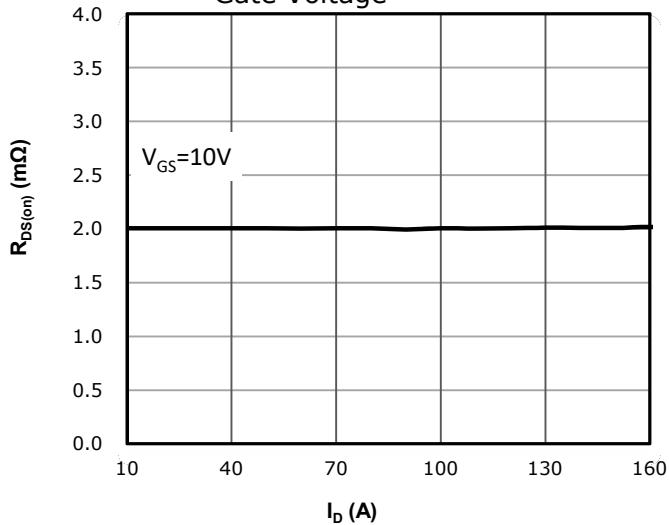
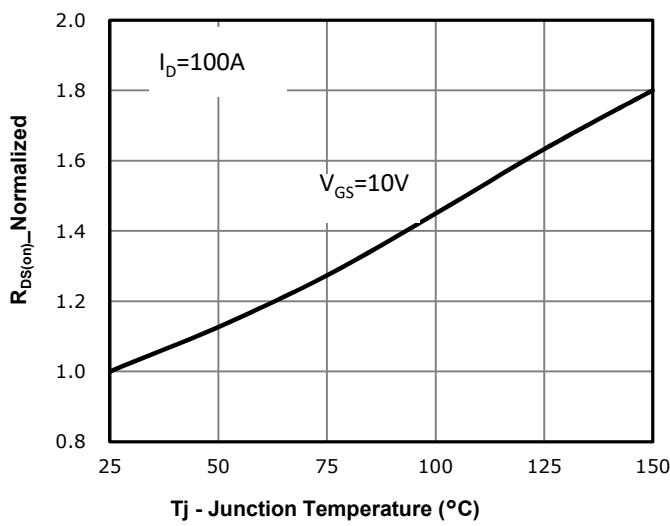
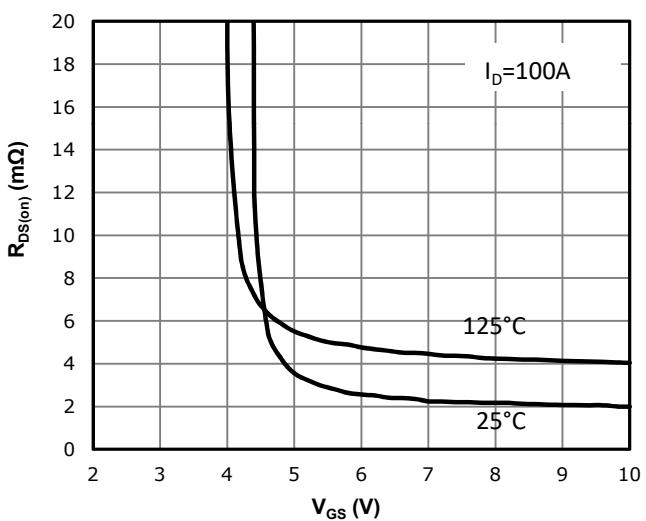

 Fig 3: R_{d(on)} vs Drain Current and Gate Voltage

 Fig 5: R_{d(on)} vs. Temperature

 Fig 4: R_{d(on)} vs Gate Voltage


Fig 6: Capacitance Characteristics

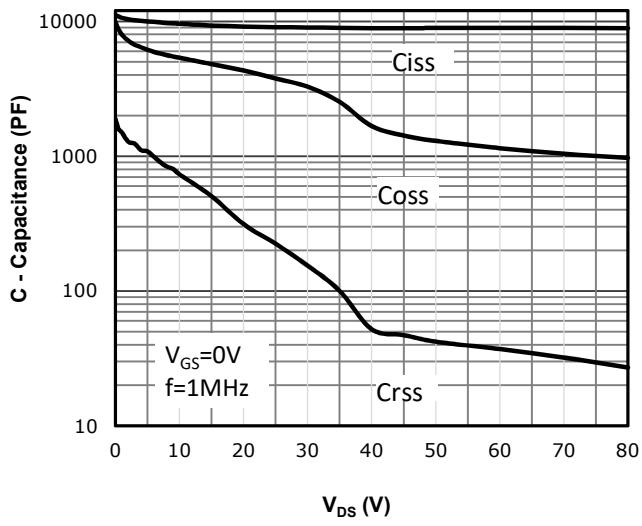


Fig 7: Gate Charge Characteristics

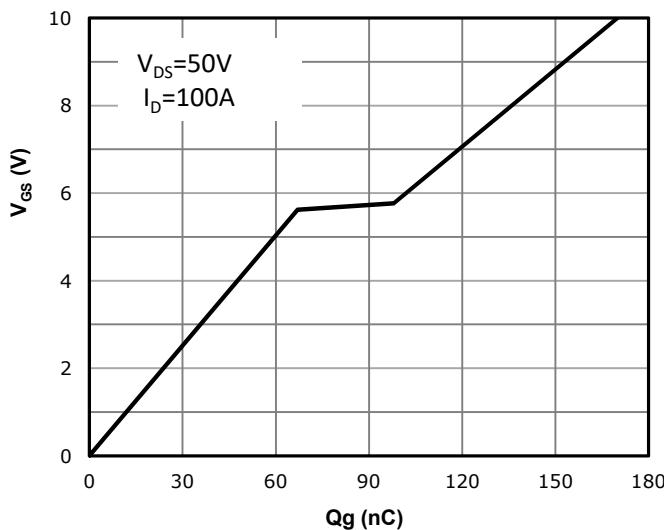


Fig 8: Body-diode Forward Characteristics

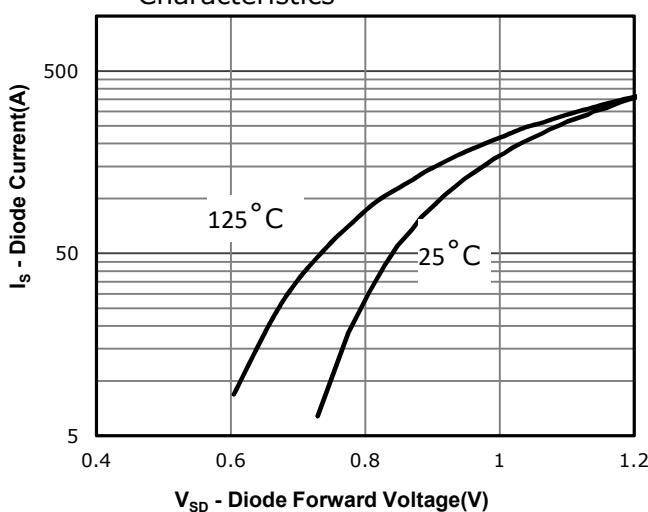


Fig 9: Power Dissipation

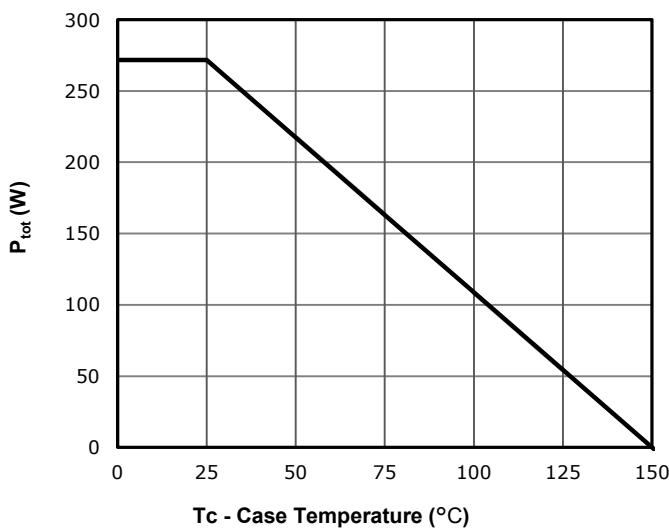


Fig 10: Drain Current Derating

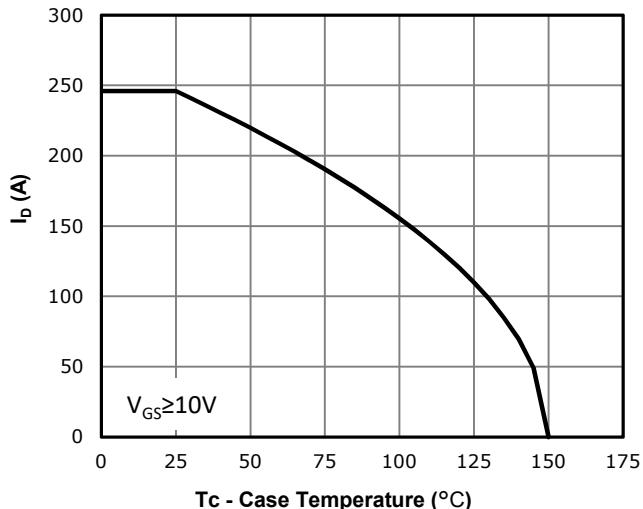


Fig 11: Safe Operating Area

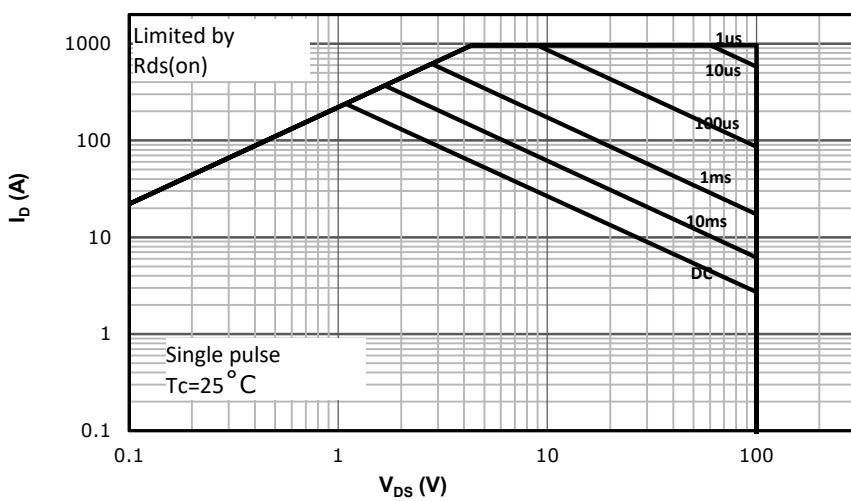
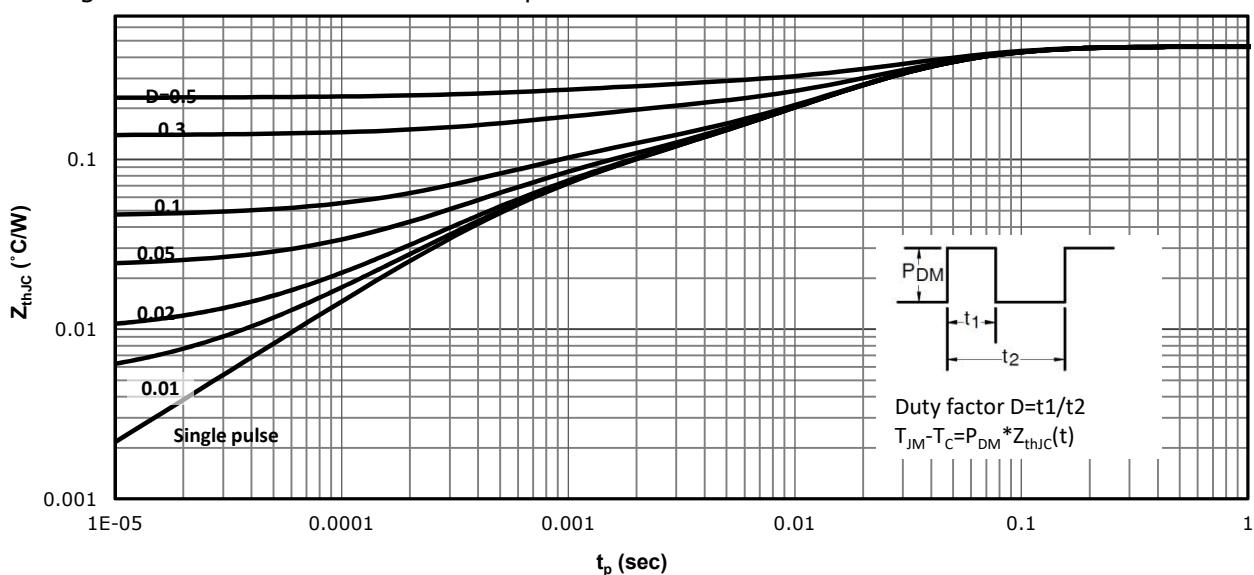
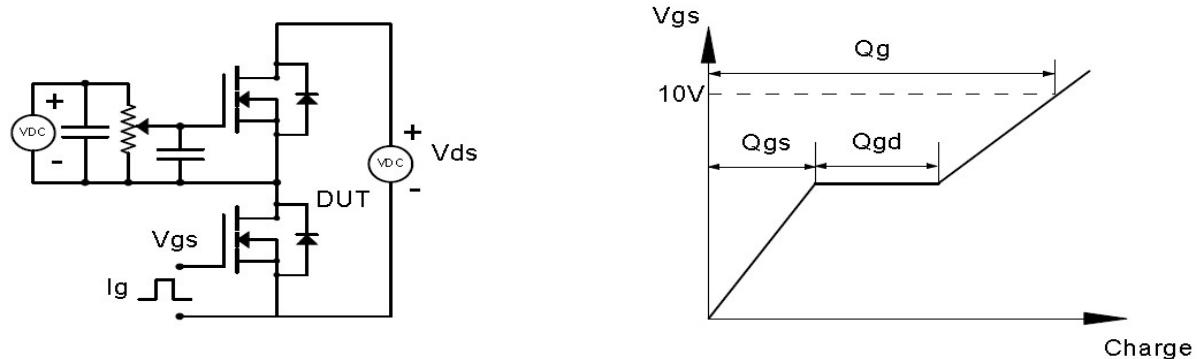


Fig 12: Max. Transient Thermal Impedance

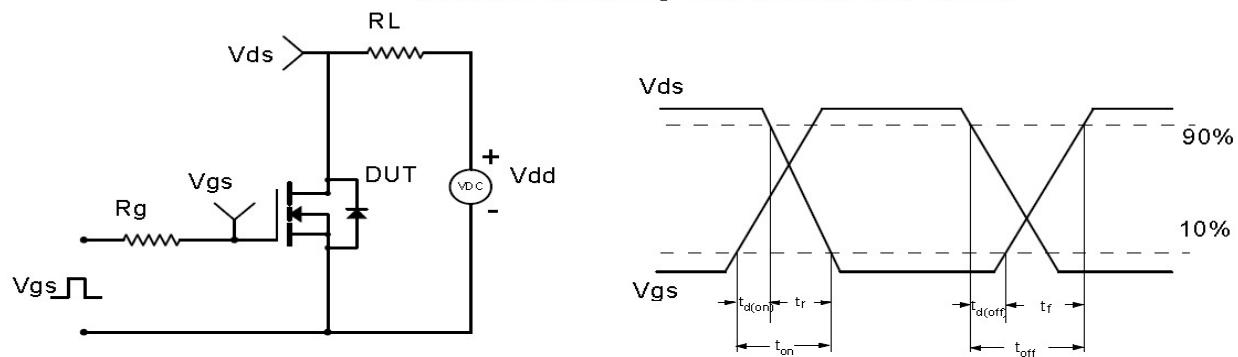


Test Circuit & Waveform

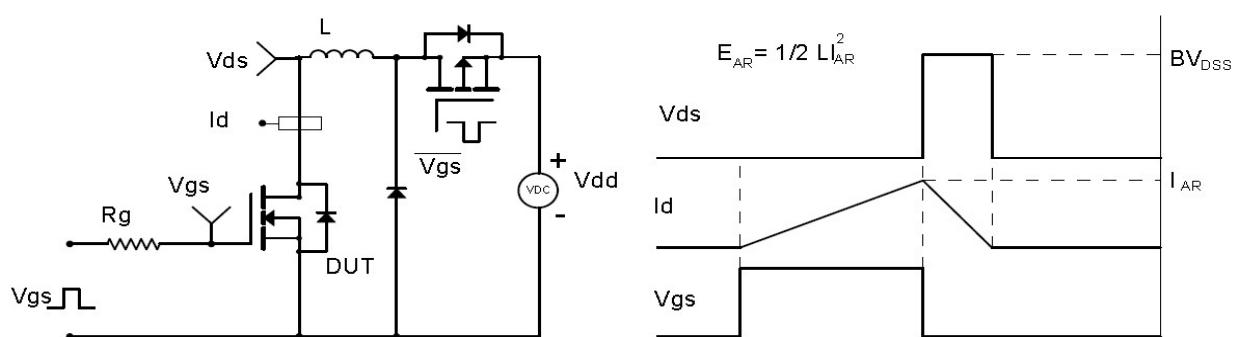
Gate Charge Test Circuit & Waveform



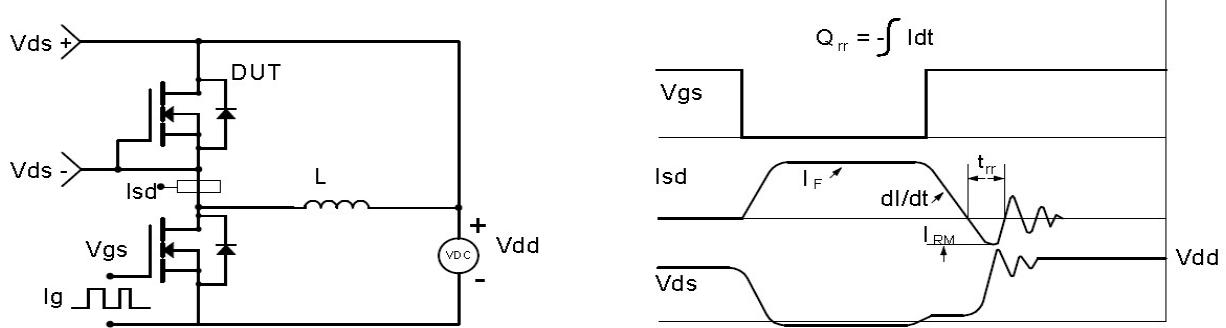
Resistive Switching Test Circuit & Waveforms



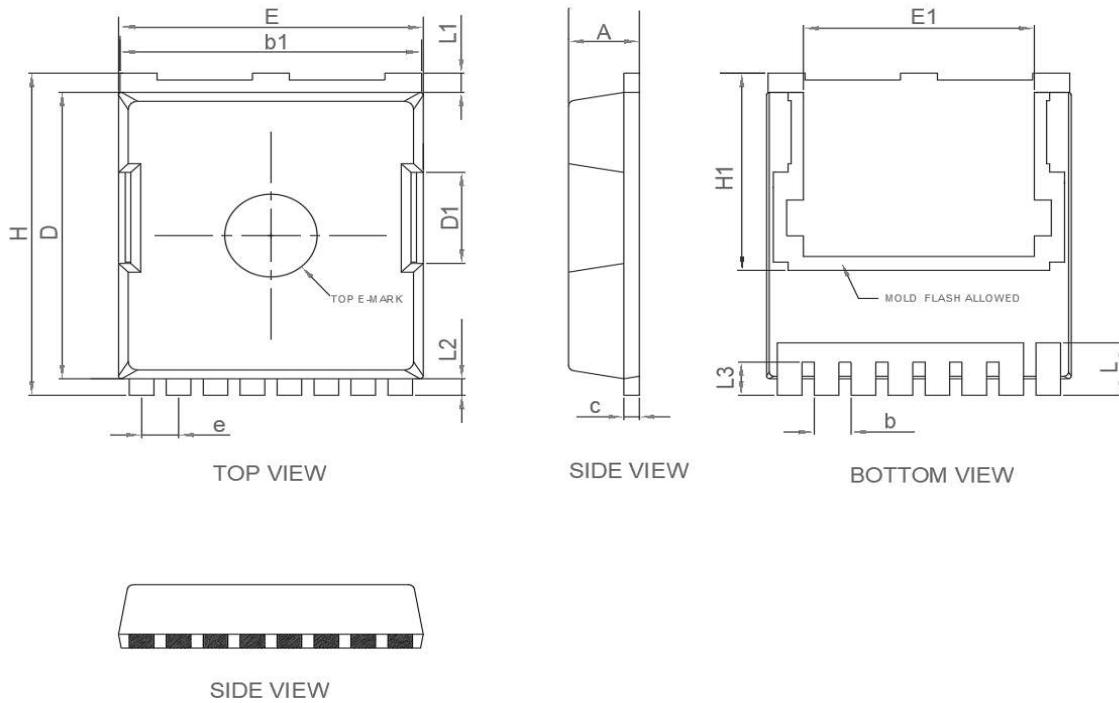
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: TOLLA



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.15	2.45	0.085	0.096
b	0.70	0.90	0.028	0.035
b1	9.65	9.95	0.380	0.392
c	0.40	0.60	0.016	0.024
D	10.18	10.58	0.401	0.417
D1	3.15	3.45	0.124	0.136
E	9.70	10.10	0.382	0.398
E1	7.35	8.45	0.289	0.333
e	1.10	1.30	0.043	0.051
H	11.45	11.90	0.451	0.469
H1	6.70	7.50	0.264	0.295
L	1.60	2.10	0.063	0.083
L1	0.50	0.90	0.020	0.035
L2	0.45	0.75	0.018	0.030
L3	1.00	1.30	0.039	0.051



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CRSZ025N10NZ

SkyMOS1 N-MOSFET 100V, 2mΩ, 240A

Revision History

Revison	Date	Major changes
1.0	2022/11/4	Release of Formal version.

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.